

Search Notes

Application/Control No.

10/665,482

Examiner

David Dunn

Applicant(s)/Patent under
Reexamination

YOSHIKAWA ET AL.

Art Unit

3616

SEARCHED

Class	Subclass	Date	Examiner
280	729 730.1 730.2 752	9/1/2005	DD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR